

PUNYASHLOK AHILYADEVI HOLKAR SOLAPUR UNIVERSITY, SOLAPUR

EXAM OF 2020 SEMESTER PATTERN EXAMINATION

FINAL PROGRAM OF M.SC. (NANO-TECHNOLOGY) SEMESTER - I TOIV MARCH 2020 EXAMINATION TO BE HELD IN OCT-2020

- **1.** The Candidates at the above examination are requested to be present **FIFTEEN MINUTES** before the time starting of the first paper and **TEN MINUTES** before the time appointed for starting of each subsequent paper. Candidates are forbidden to take any book or paper into the Examination Hall.
- **2.** The Examination Programme is subject to change. If there is any change in the Examination Programme the University is not responsible for the loss or inconvenience caused to the candidates.
- **3.** The external candidates are requested to see their examination seat number as well as place of the examination on the notice board of the University/College at least two days before the date of examination.
- **4.** Cellular Phone, Pager, Scientific Calculator, Digital Diary or any means, which can be used for unfair practice, are not allowed in the Examination Hall.
- **5.** <u>Important Note:</u> Code Numbers given in the Bracket are Computer Code of respective Subjects, Students should mention these Code Numbers on Answer Books with Name of the Subject. Also write these Code Numbers on JSR (Junior Supervisor Report) and related documents.

6.The Time for the exam is one and haf hour (1 ½) only.

- The written examination will be conducted online/offline mode which will be held at home/desegnated places.
- 8. All the student are here by informed that the time slot given in the time table shows 5 hrs for each day. But you will get 1 ½ hrs to solve the paper. If any student has two paper in one day that time he will be solving two papers within 5 hours.

Nano-Technology Sem – I (w.e.f. June 2016)							
(CBCS Pattern-2016)							
Day & Date	Paper No.	Sr. No	Subject TIME: 11:00 a.m. to 4:00 p.m. (Only 1 ½ hrs out of this slot)				
Monday 05/10/2020	HCT1.1	403	Fundamentals of Nano Technology in Physics (21723101)				
Tuesday 06/10/2020	HCT1.2	404	Fundamentals of Nano Technology in Chemistry (21723102)				
Wednesday 07/10/2020	HCT1.3	405	Nano-materials Fabrication (21723103)				
Thursday 08/10/2020	SCT1.1	406	A] Fundamentals of Biotechnology (21723104) OR				
	SCT1.2	407	B] Introduction to Nano science and Nanotechnology (21723105)				

Nano-Technology Sem – II (w.e.f. Nov 2016)							
(CBCS Pattern-2016)							
Day & Date	Paper No.	Sr. No	Subject TIME: 11:00 a.m. to 4:00 p.m. (Only 1 ½ hrs out of this slot)				
Monday 05/10/2020	HCT2.1	408	Characterization Tools of Nanomaterials (21723201)				
Tuesday 06/10/2020	HCT2.2	409	Properties of Nanomaterials (21723202)				
Wednesday 07/10/2020	SCT2.1 SCT2.2	410 411	A) Carbon and Nanoforms of Carbon (21723203) OR B) Nano-electronics (21723204)				
Saturday 17/10/2020	OET		[Choose from list]				

Nano-Technology Sem – III (w.e.f. June 2017)						
(CBCS Pattern-2016)						
Day & Date	Paper No.	Sr. No.	Subject TIME: 11:00 a.m. to 4:00 p.m. (Only 1 ½ hrs out of this slot)			
Monday 05/10/2020	HCT3.1	412	Nanotechnology and Health-care (21723301)			
Tuesday 06/10/2020	НСТЗ.2	413	Application of Nanotechnology in Everyday Life (21723302)			
Wednesday 07/10/2020	SCT3.1 SCT3.2	414	A) Nanotechnology in Environment/Ecosystem (21723306) OR B) Organic Semiconductors, Polymers & Molecular Electronics (21723307)			
Sunday 18/10/2020	OET		[Choose from list]			

Nano-Technology Sem – IV (w.e.f. Nov 2017) (CBCS Pattern-2016)						
Day & Date	Paper No.	Sr. No.	Subject TIME: 11:00 a.m. to 4:00 p.m. (Only 1 ½ hrs out of this slot)			
Monday 12/10/2020	HCT4.1	416	Polymers & Nanocomposites (217234-01)			
Tuesday 13/10/2020	HCT4.2	417	Industrial Nanotechnology (217234-02)			
Wednesday 14/10/2020	НСТ4.3	418	Thin film Technology (217234-03)			
Thursday 15/10/2020	SCT4.1	419	A] Nano devices and Nano Sensors (217234-06) OR			
	SCT4.2	420	B]Animal Biotechnology (217234-07)			

Please visit -http://su.digitaluniversity.ac

Ref No.: PAHSUS/EXAM/TIME-TABLE/2020/778

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Sd/-

Date : 19/09/2020 Board of Examinations and Evaluation